

Notice of References Cited	Application/Control No. 10/562,438	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
	Examiner Ben Lewis	Art Unit 1745	Page 1 of 1

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*	D	US-6,365,300 B1	04-2002	Ota et al.	429/304
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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